

Notice of References Cited	Application/Control No.	Applicant(s)/Patent Under Reexamination	
	10/568,981	CHEN, LINFENG	
Examiner		Art Unit	Page 1 of 1
Ling-Siu Choi		1713	

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,432,244	07-1995	Rebhan, David M.	526/124.8
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	JP 61-203105	09-1986	Japan	Tanaka	---
*	O	EP 0 490 451 A2	06-1992	Europe	Rebhan et al.	---
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.